

# Longitudinal bunch profile measurements with TDS

## 1nC bunch:

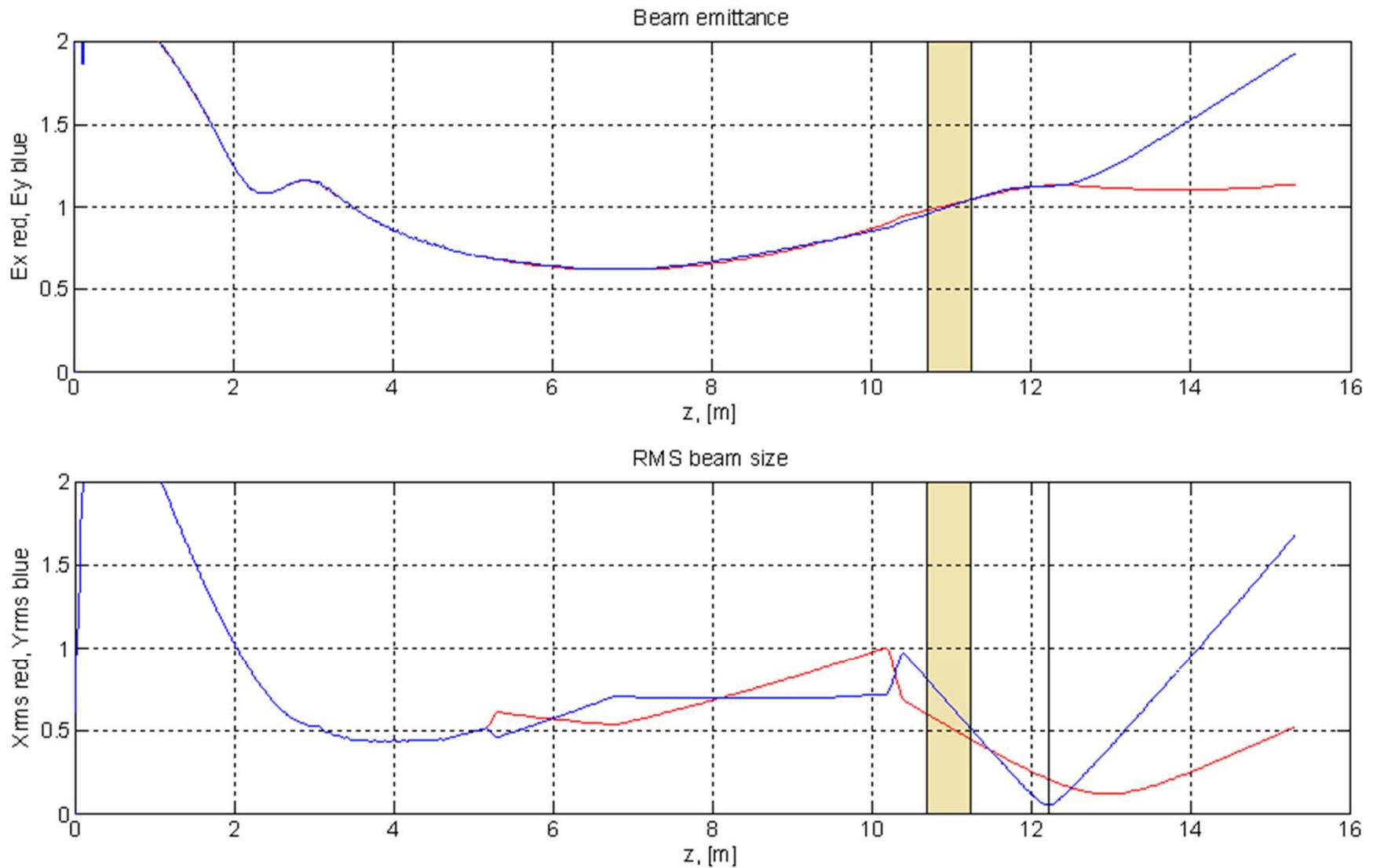
- Beam optics
- TDS calibration
- Measurement results

## 100pC bunch, special profile:

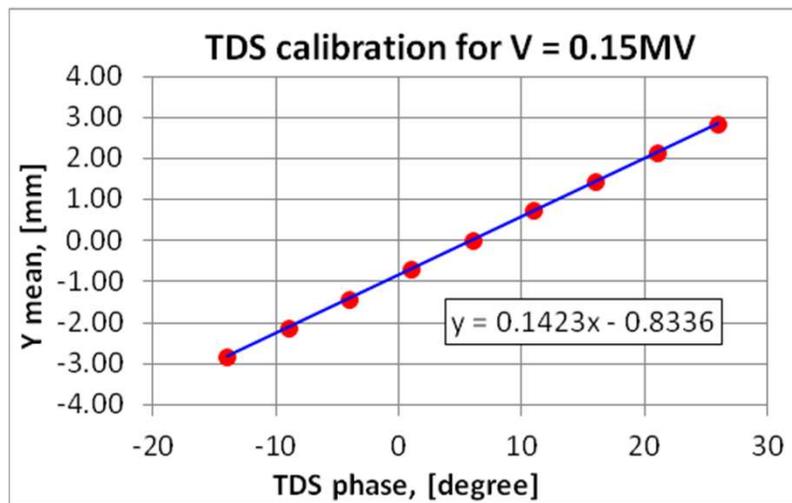
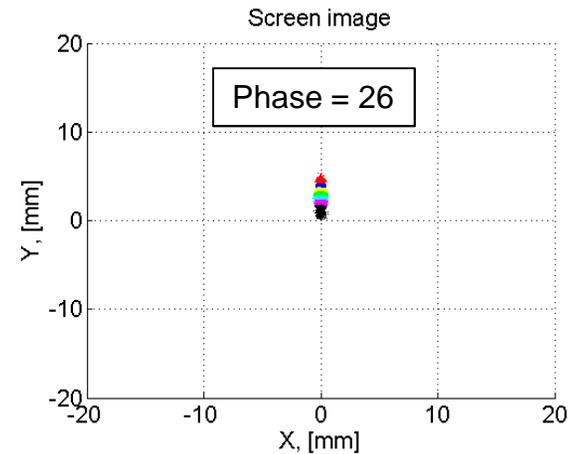
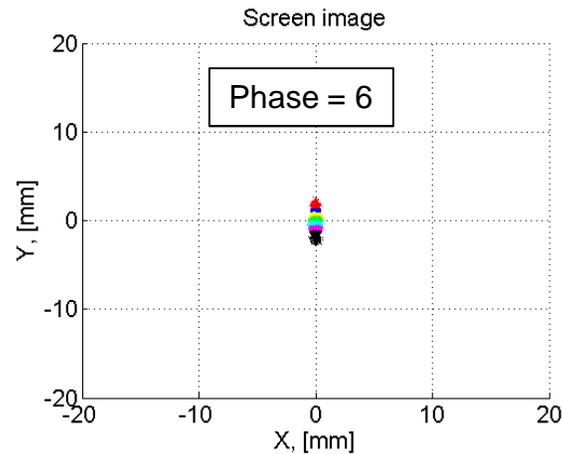
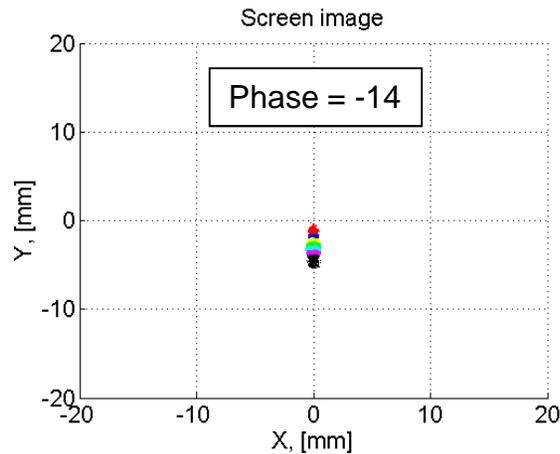
- Beam optics
- TDS calibration
- Measurement results

Dmitriy Malyutin  
PITZ physics seminar  
Zeuthen, December 21, 2011

# Beam optics, ASTRA simulation, 1nC



# TDS calibration at PST.Scr1, 1nC bunch charge



$$S = \frac{K_1 \cdot 360 \cdot f}{\beta \cdot c} = 0.51$$

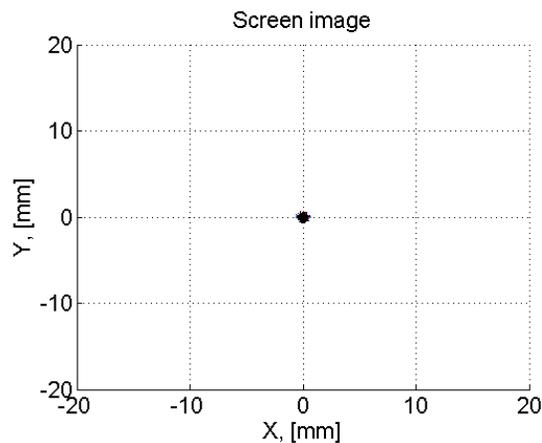
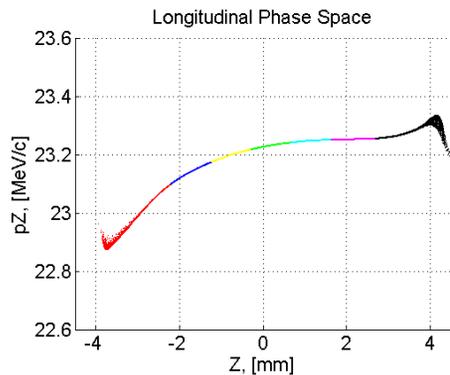
$$S(0.6MV) = 2.046$$

$$S(1.2MV) = 4.092$$



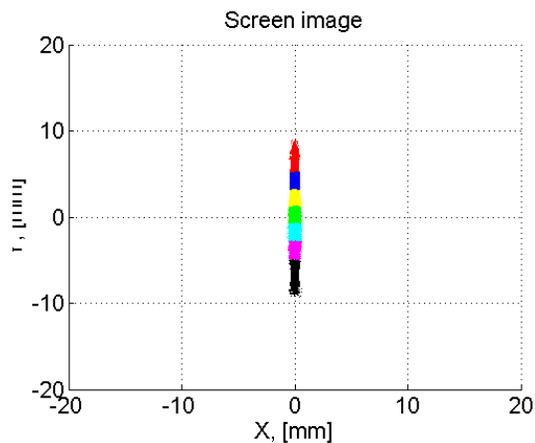
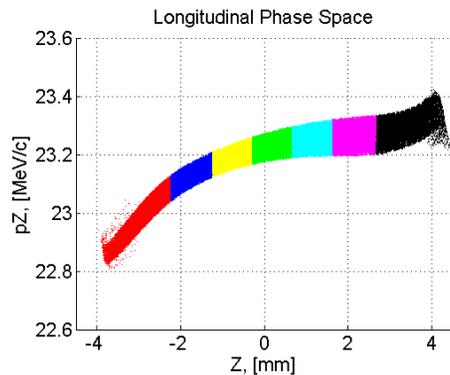
# First screen after TDS at 12.238m (PST.Scr1), 1nC

$V_0=0.0\text{MV}$



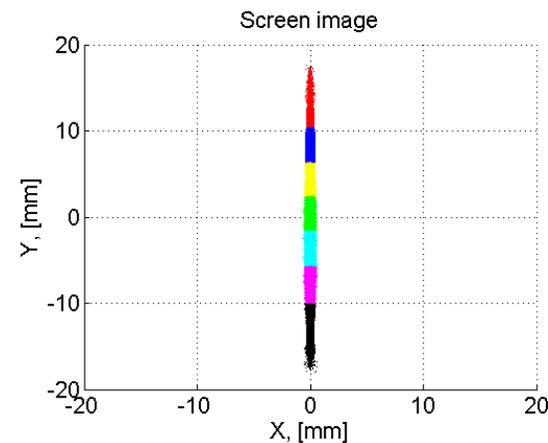
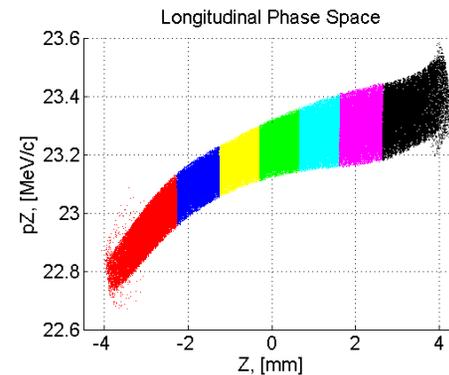
**$X_{rms} = 0.21\text{mm}$**   
 **$Y_{rms} = 0.05\text{mm}$**

$V_0=0.6\text{MV}$



**$S = 2.0$**   
 **$\sigma_z = 25\mu\text{m} = 80\text{fs}$**

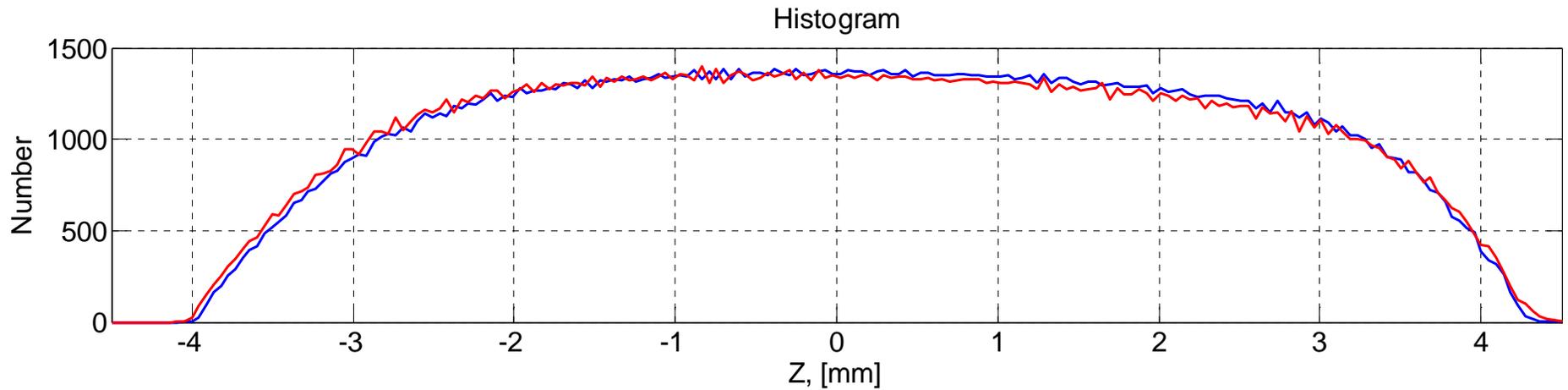
$V_0=1.2\text{MV}$



**$S = 4.0$**   
 **$\sigma_z = 12\mu\text{m} = 40\text{fs}$**



# Bunch longitudinal profile, 1nC

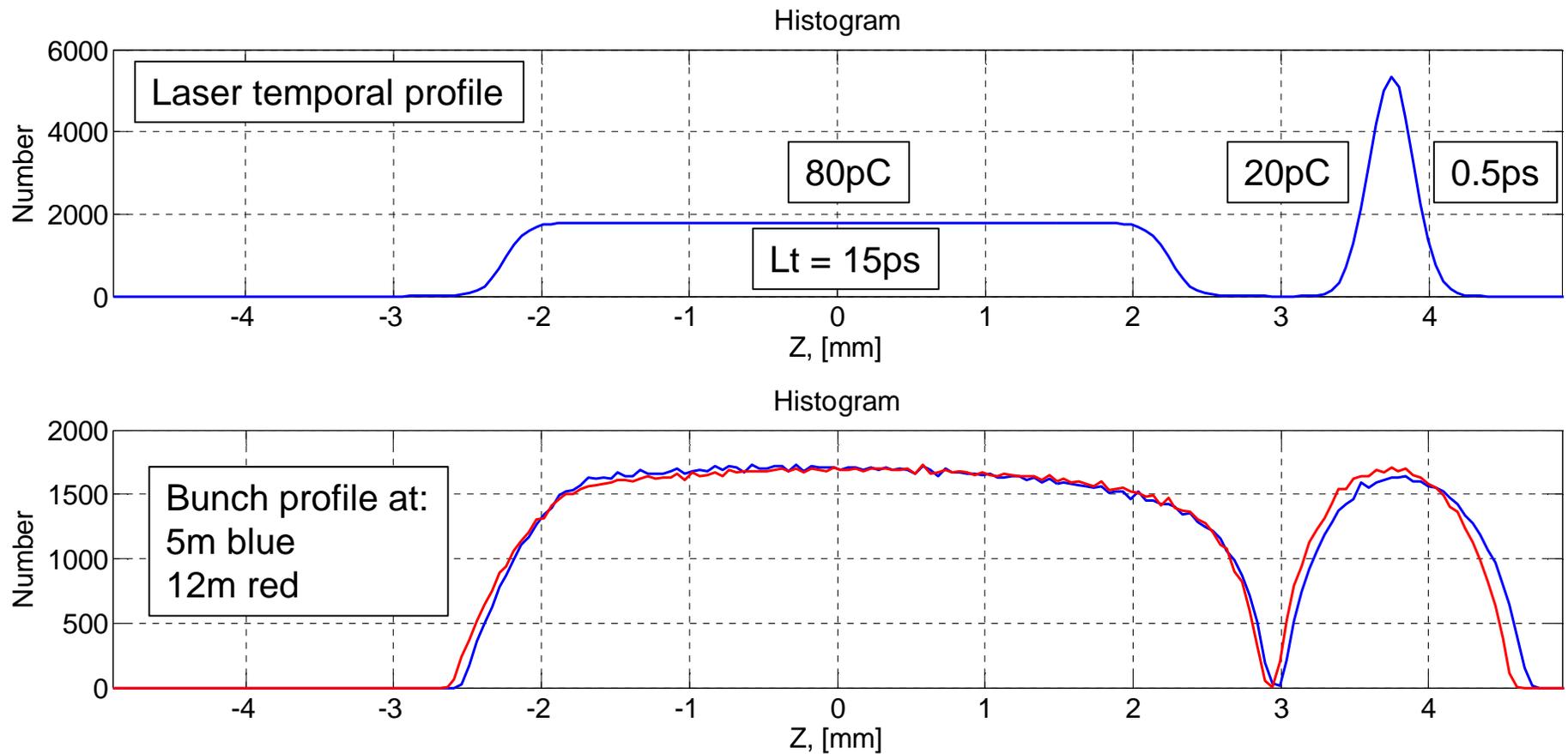


Blue line – bunch longitudinal profile at screen position

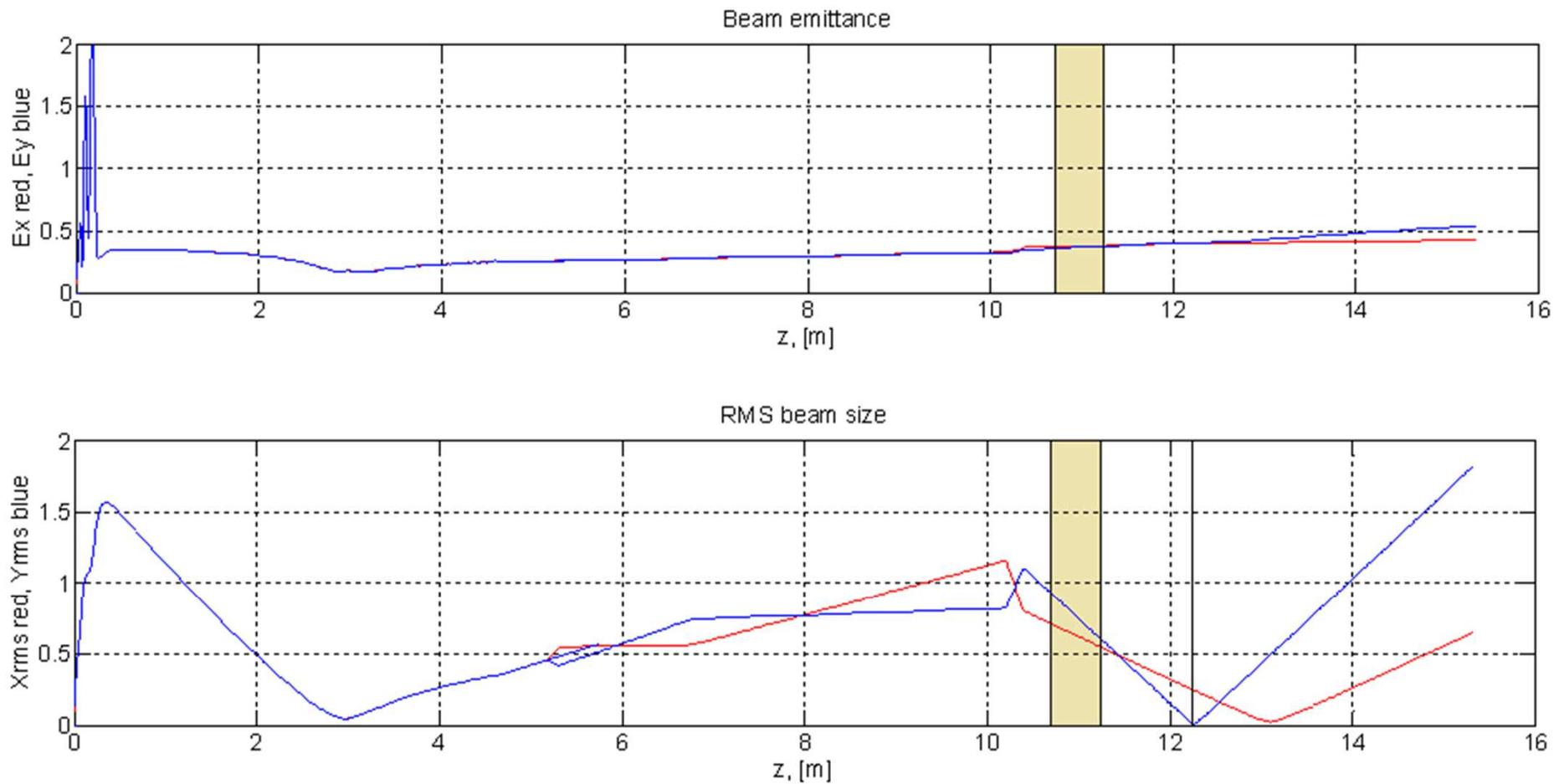
Red line – vertical profile of bunch image at screen scaled with  $S = 4.1$ .



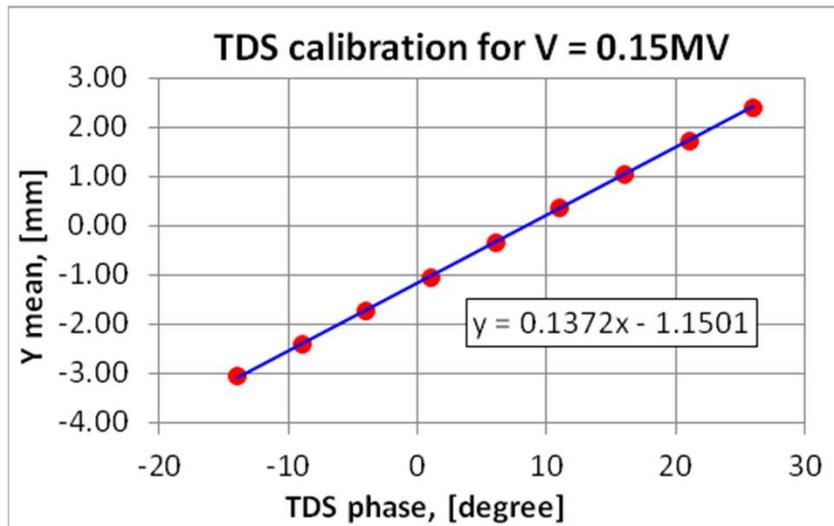
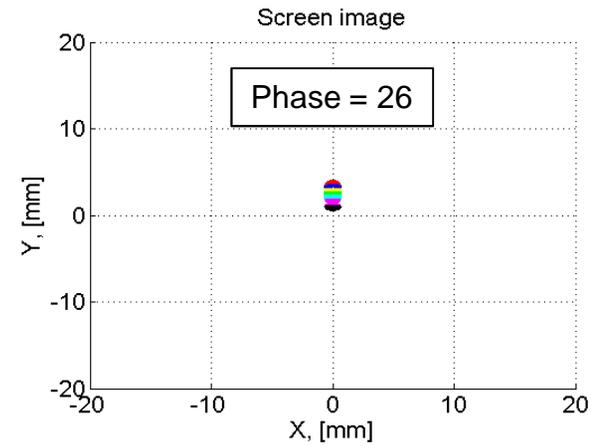
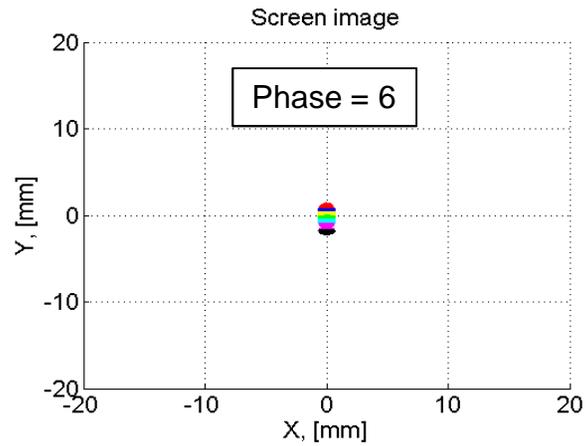
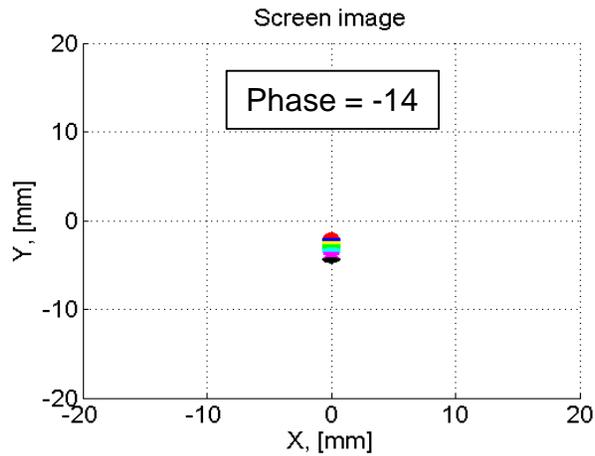
# Simulation with 100pC, special profile



# Beam optics, ASTRA simulation, 100pC



# TDS calibration at PST.Scr1, 100pC bunch charge



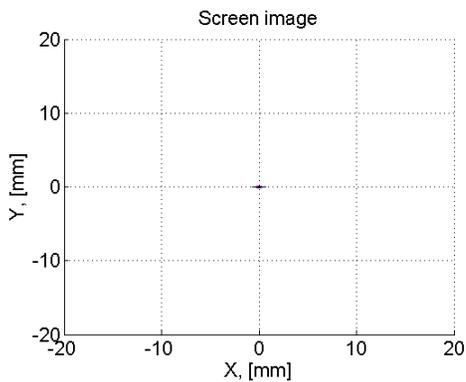
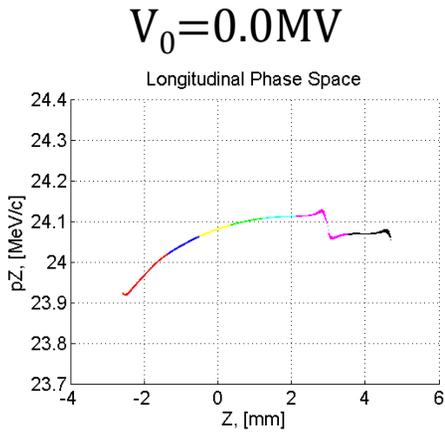
$$S = \frac{K_1 \cdot 360 \cdot f}{\beta \cdot c} = 0.49$$

$$S(0.6MV) = 1.977$$

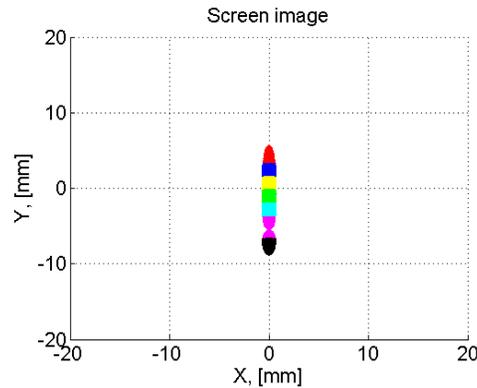
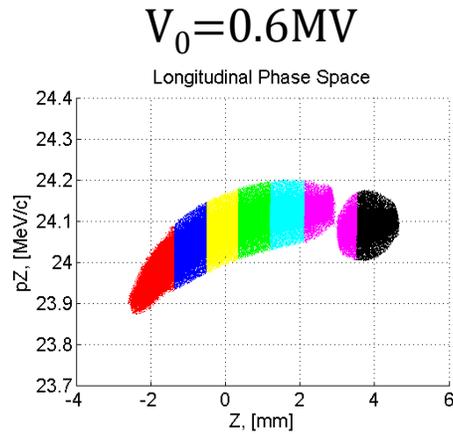
$$S(1.2MV) = 3.954$$



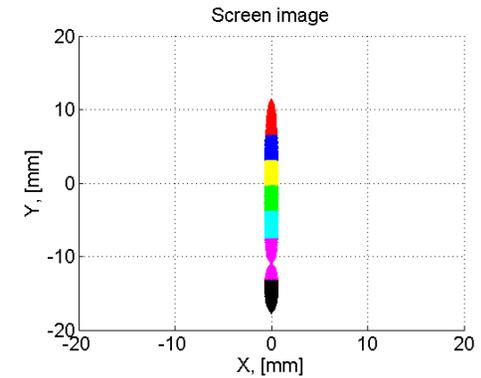
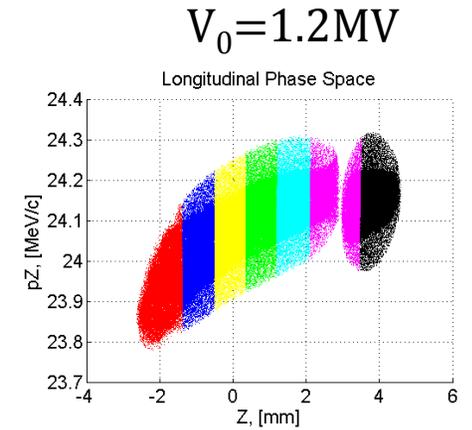
# First screen after TDS at 12.238m (PST.Scr1), 100pC



$X_{rms} = 0.256\text{mm}$   
 $Y_{rms} = 0.024\text{mm}$



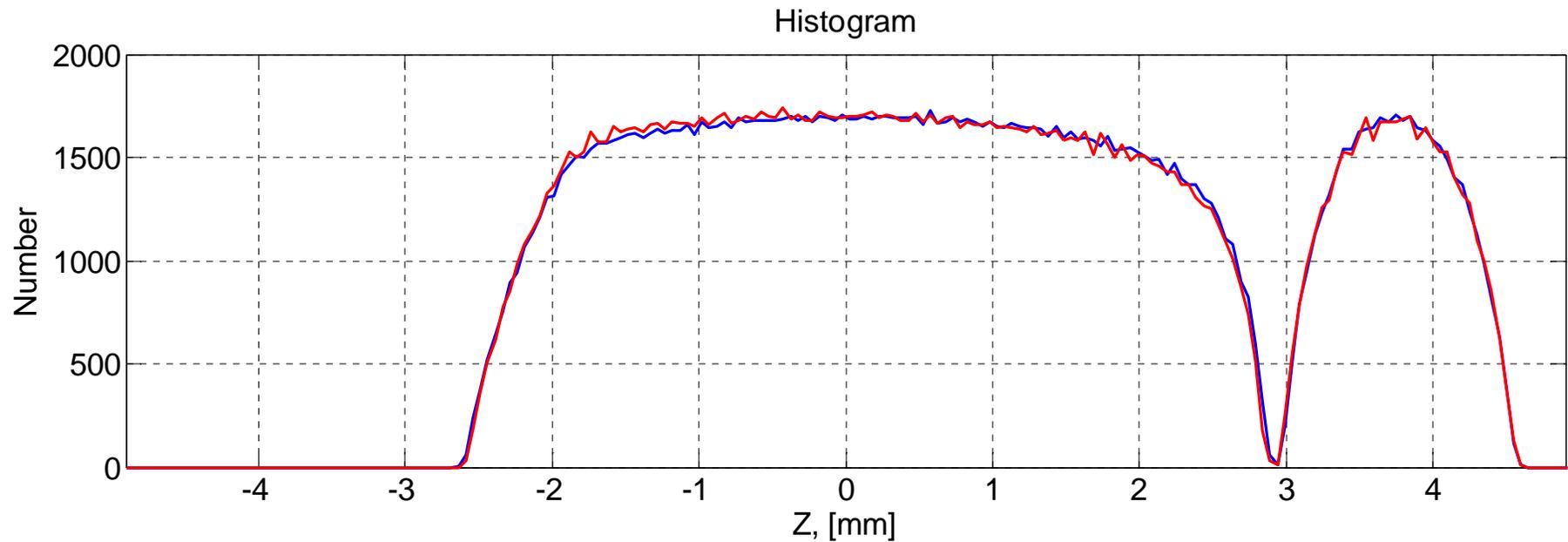
$S = 2.0$   
 $\sigma_z = 12\mu\text{m} = 40\text{fs}$



$S = 4.0$   
 $\sigma_z = 6\mu\text{m} = 20\text{fs}$



# Bunch longitudinal profile, 100pC



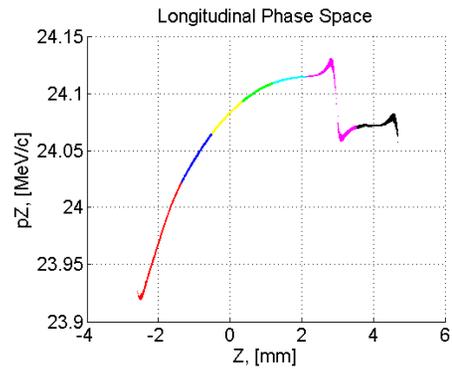
Blue line – bunch longitudinal profile at screen position

Red line – vertical profile of bunch image at screen Scaled with  $S = 4$

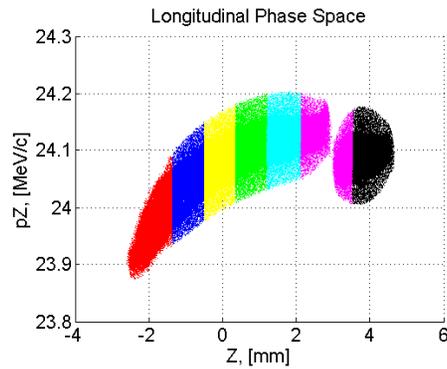


# First screen after TDS at 12.238m (PST.Scr1), 100pC

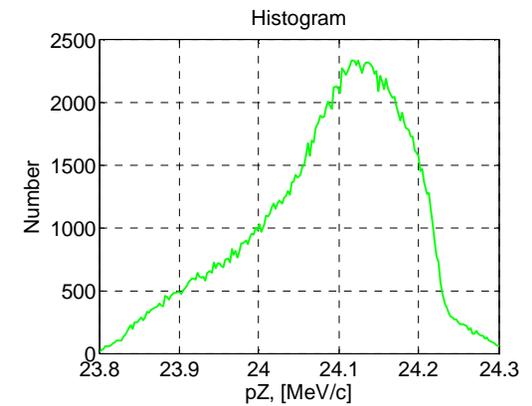
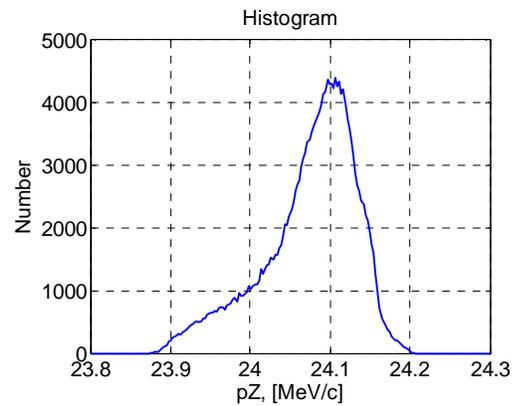
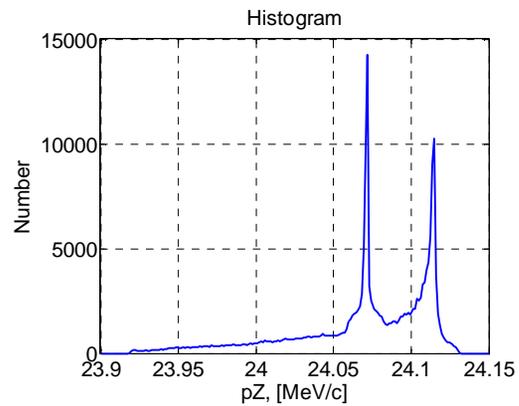
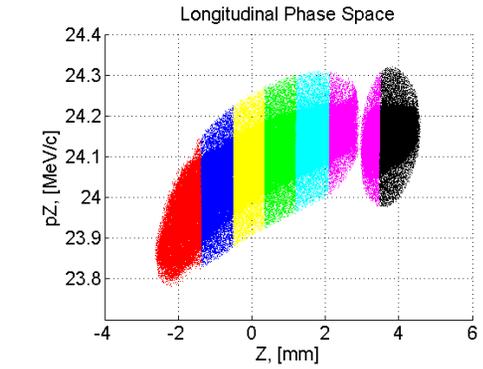
$V_0=0.0\text{MV}$



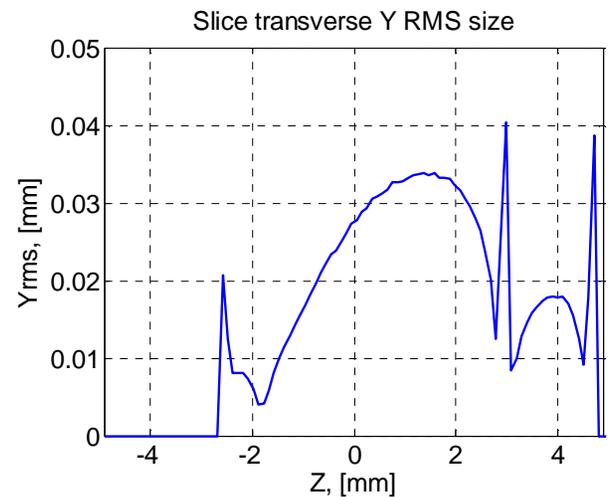
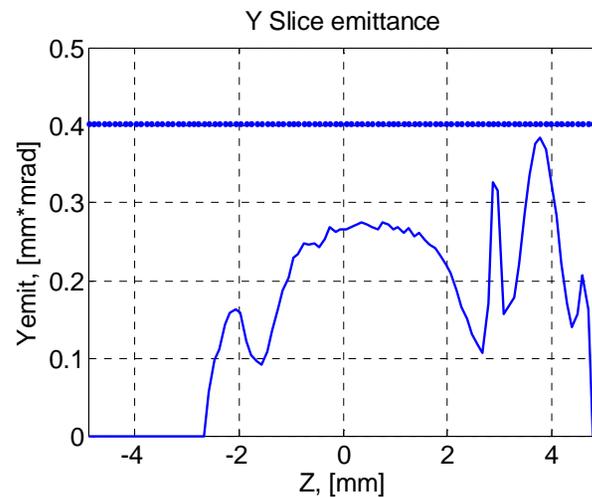
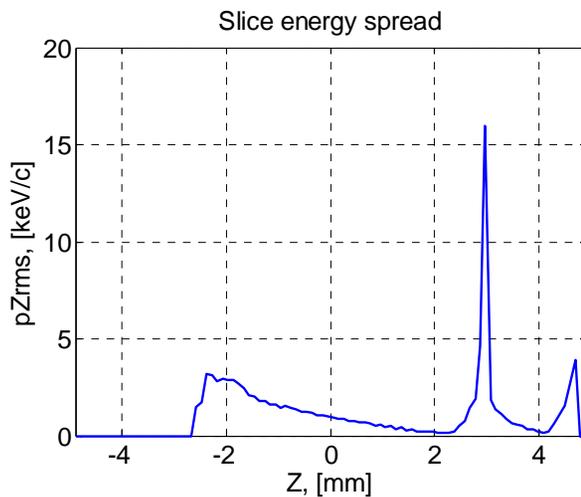
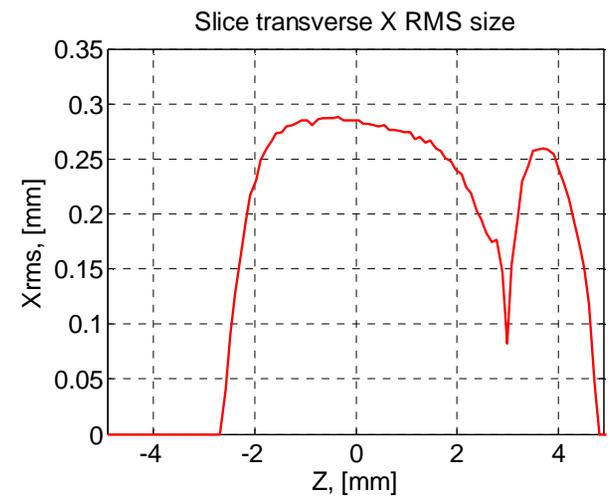
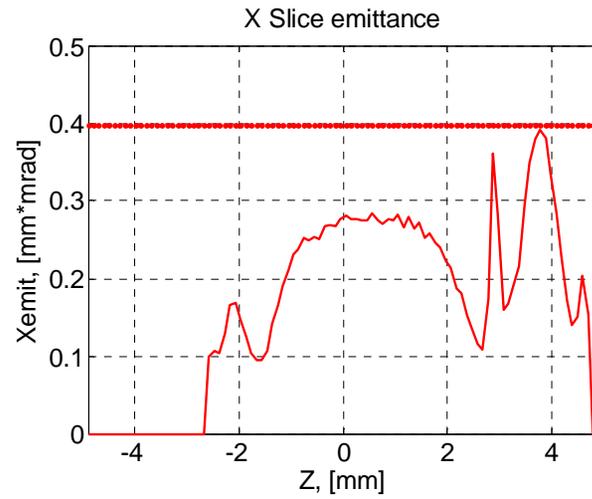
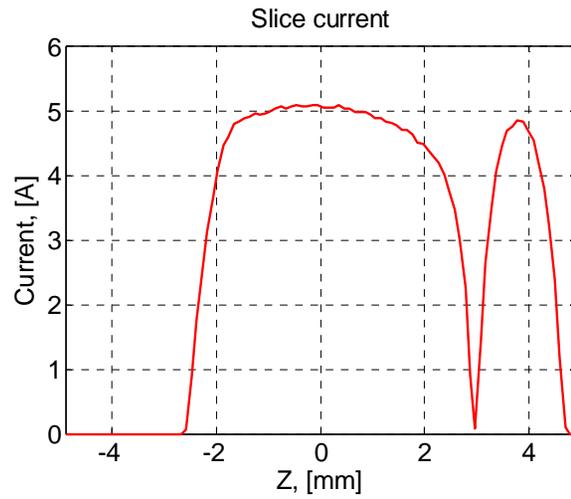
$V_0=0.6\text{MV}$



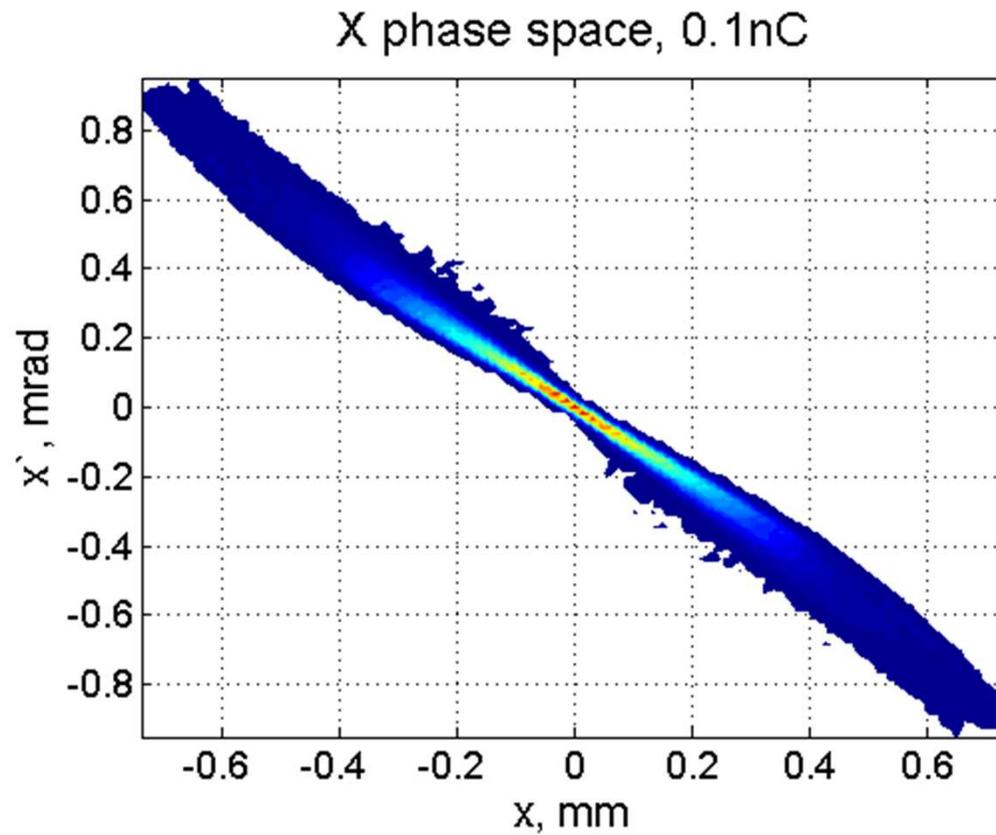
$V_0=1.2\text{MV}$



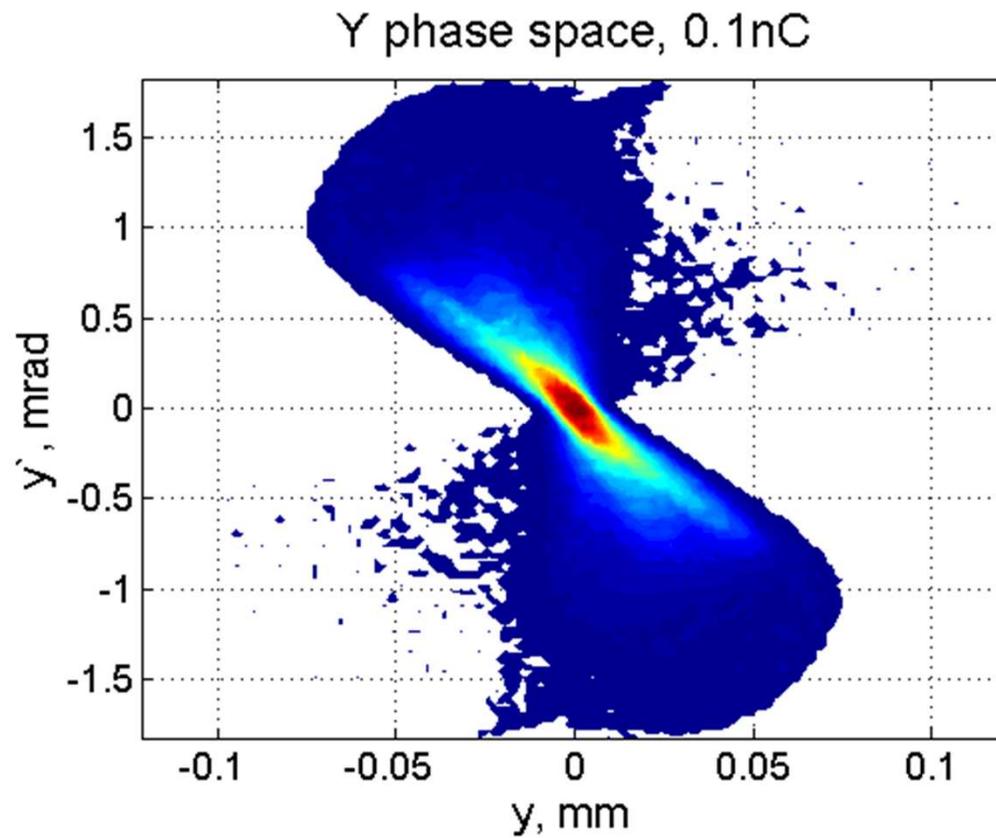
# Slice parameters at PST.Scr1 position



# X plane



# Y plane

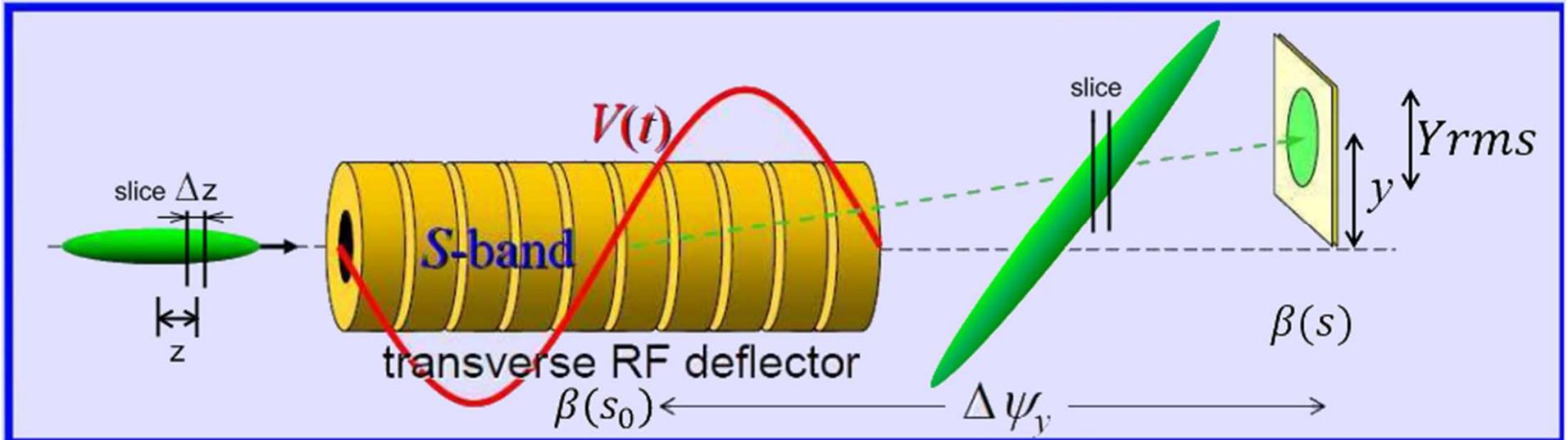


# Conclusion

- > Measured bunch longitudinal profiles look identical to the reals.
- > Achieved longitudinal resolution is **6 $\mu\text{m}$**  or **20fs** for **100pC** bunch, and **12 $\mu\text{m}$**  or **40fs** for **1nC** bunch charge.



# TDS resolution



$$S = \sqrt{\beta(s) \cdot \beta(s_0)} \cdot \sin(\Delta\psi_y) \cdot \frac{eV_0 k}{pc} \quad (1)$$

$$\sigma_z = \frac{\sigma_y}{S} \quad (2)$$

# TDS resolution

$$\sigma_z = \frac{\sqrt{\varepsilon}}{\sqrt{\beta(s_0)}} \cdot \frac{pc}{eV_0 k} = \frac{\varepsilon \gamma mc^2}{\sigma_y(s_0) eV_0 k} = \frac{\varepsilon_N}{\sigma_y(s_0)} \cdot \frac{mc^2}{eV_0 k}, \quad (3) \quad k = \frac{2\pi f}{c}$$

**PITZ:** 
$$\sigma_z = \frac{0.4 \cdot 10^{-6} m \cdot rad}{800 \cdot 10^{-6} m} \cdot \frac{0.5 MeV}{1.2 MeV \cdot 63 m^{-1}} = 3.4 \cdot 10^{-6} m, \text{ or } 11 \text{ fs}$$



# TDS induced slice energy spread

$$\sigma_\delta = \frac{eV_0 k}{p_0 c} \sigma_y(s_0), \quad (4)$$

$$\text{where } \delta = \frac{\Delta p}{p}.$$

**PITZ:** 
$$\sigma_\delta = \frac{1.2 \text{ MeV} \cdot 63 \text{ m}^{-1}}{23 \text{ MeV}} \cdot 800 \cdot 10^{-6} \text{ m} = 2.6 \cdot 10^{-3} \text{ or } 60 \text{ keV}$$

